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Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

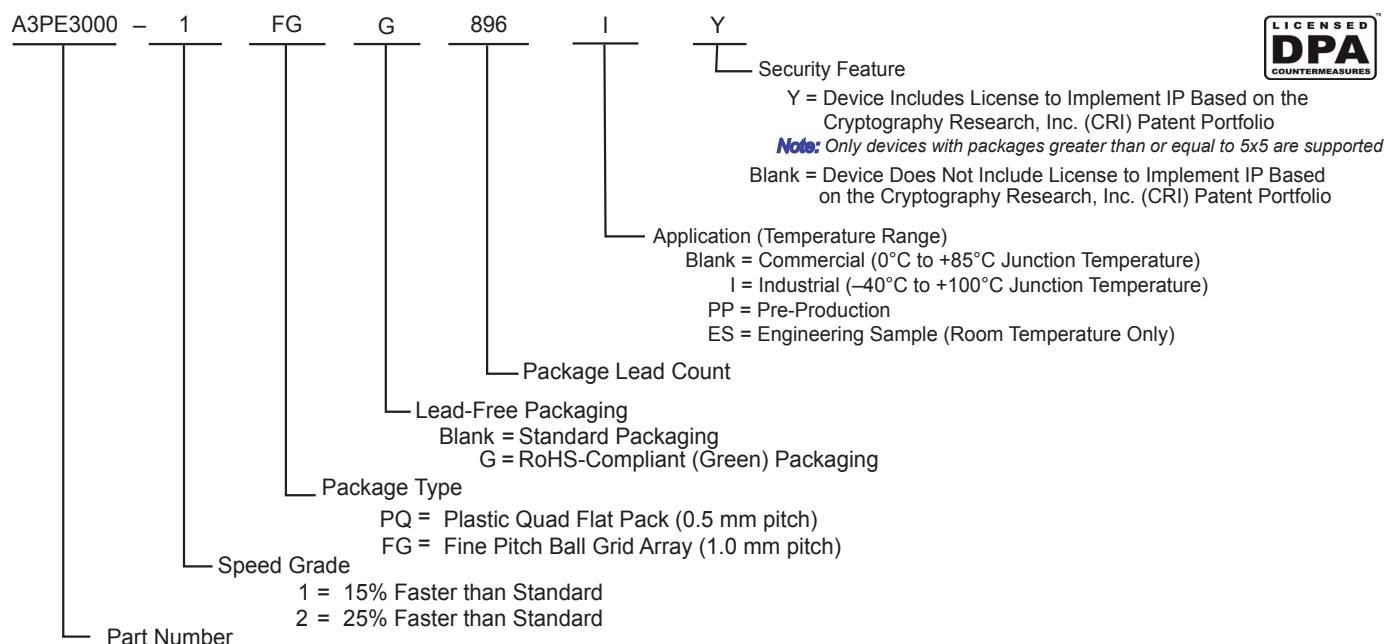
Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

| | |
|--------------------------------|---|
| Product Status | Active |
| Number of LABs/CLBs | - |
| Number of Logic Elements/Cells | - |
| Total RAM Bits | 276480 |
| Number of I/O | 444 |
| Number of Gates | 1500000 |
| Voltage - Supply | 1.425V ~ 1.575V |
| Mounting Type | Surface Mount |
| Operating Temperature | -40°C ~ 100°C (TJ) |
| Package / Case | 676-BGA |
| Supplier Device Package | 676-FBGA (27x27) |
| Purchase URL | https://www.e-xfl.com/product-detail/microchip-technology/m1a3pe1500-2fgg676i |

ProASIC3E Ordering Information



ProASIC3E Devices

A3PE600 = 600,000 System Gates
A3PE1500 = 1,500,000 System Gates
A3PE3000 = 3,000,000 System Gates

ProASIC3E Devices with Cortex-M1

M1A3PE1500 = 1,500,000 System Gates
M1A3PE3000 = 3,000,000 System Gates

Table 2-2 • Recommended Operating Conditions¹

| Symbol | Parameter | | Commercial | Industrial | Units |
|---------------------------|--------------------------------------|-------------------------------|----------------|----------------|-------|
| T _A | Ambient temperature | | 0 to +70 | −40 to +85 | °C |
| T _J | Junction temperature | | 0 to +85 | −40 to +100 | °C |
| VCC | 1.5 V DC core supply voltage | | 1.425 to 1.575 | 1.425 to 1.575 | V |
| VJTAG | JTAG DC voltage | | 1.4 to 3.6 | 1.4 to 3.6 | V |
| VPUMP | Programming voltage | Programming Mode ² | 3.15 to 3.45 | 3.15 to 3.45 | V |
| | | Operation ³ | 0 to 3.6 | 0 to 3.6 | V |
| VCCPLL | Analog power supply (PLL) | | 1.425 to 1.575 | 1.425 to 1.575 | V |
| VCCI and VMV ⁴ | 1.5 V DC supply voltage | | 1.425 to 1.575 | 1.425 to 1.575 | V |
| | 1.8 V DC supply voltage | | 1.7 to 1.9 | 1.7 to 1.9 | V |
| | 2.5 V DC supply voltage | | 2.3 to 2.7 | 2.3 to 2.7 | V |
| | 3.3 V DC supply voltage | | 3.0 to 3.6 | 3.0 to 3.6 | V |
| | 3.0 V DC supply voltage ⁵ | | 2.7 to 3.6 | 2.7 to 3.6 | V |
| | LVDS/B-LVDS/M-LVDS differential I/O | | 2.375 to 2.625 | 2.375 to 2.625 | V |
| | LVPECL differential I/O | | 3.0 to 3.6 | 3.0 to 3.6 | V |

Notes:

1. All parameters representing voltages are measured with respect to GND unless otherwise specified.
2. The programming temperature range supported is $T_{\text{ambient}} = 0^{\circ}\text{C}$ to 85°C .
3. VPUMP can be left floating during normal operation (not programming mode).
4. The ranges given here are for power supplies only. The recommended input voltage ranges specific to each I/O standard are given in [Table 2-13 on page 2-16](#). VMV and VCCI should be at the same voltage within a given I/O bank. VMV pins must be connected to the corresponding VCCI pins. See the "[VMVx I/O Supply Voltage \(quiet\)](#)" section on [page 3-1](#) for further information.
5. To ensure targeted reliability standards are met across ambient and junction operating temperatures, Microsemi recommends that the user follow best design practices using Microsemi's timing and power simulation tools.
6. 3.3 V wide range is compliant to the JESD8-B specification and supports 3.0 V VCCI operation.

Table 2-3 • Flash Programming Limits – Retention, Storage and Operating Temperature¹

| Product Grade | Programming Cycles | Program Retention (biased/unbiased) | Maximum Storage Temperature T _{STG} (°C) ² | Maximum Operating Junction Temperature T _J (°C) ² |
|---------------|--------------------|-------------------------------------|--|---|
| Commercial | 500 | 20 years | 110 | 100 |
| Industrial | 500 | 20 years | 110 | 100 |

Notes:

1. This is a stress rating only; functional operation at any condition other than those indicated is not implied.
2. These limits apply for program/data retention only. Refer to [Table 2-1 on page 2-1](#) and [Table 2-2](#) for device operating conditions and absolute limits.

PLL Behavior at Brownout Condition

Microsemi recommends using monotonic power supplies or voltage regulators to ensure proper power-up behavior. Power ramp-up should be monotonic at least until VCC and VCCPLXL exceed brownout activation levels. The VCC activation level is specified as 1.1 V worst-case (see [Figure 2-1 on page 2-4](#) for more details).

When PLL power supply voltage and/or VCC levels drop below the VCC brownout levels ($0.75\text{ V} \pm 0.25\text{ V}$), the PLL output lock signal goes low and/or the output clock is lost. Refer to the "Power-Up/-Down Behavior of Low Power Flash Devices" chapter of the *ProASIC3E FPGA Fabric User's Guide* for information on clock and lock recovery.

Internal Power-Up Activation Sequence

1. Core
2. Input buffers
3. Output buffers, after 200 ns delay from input buffer activation

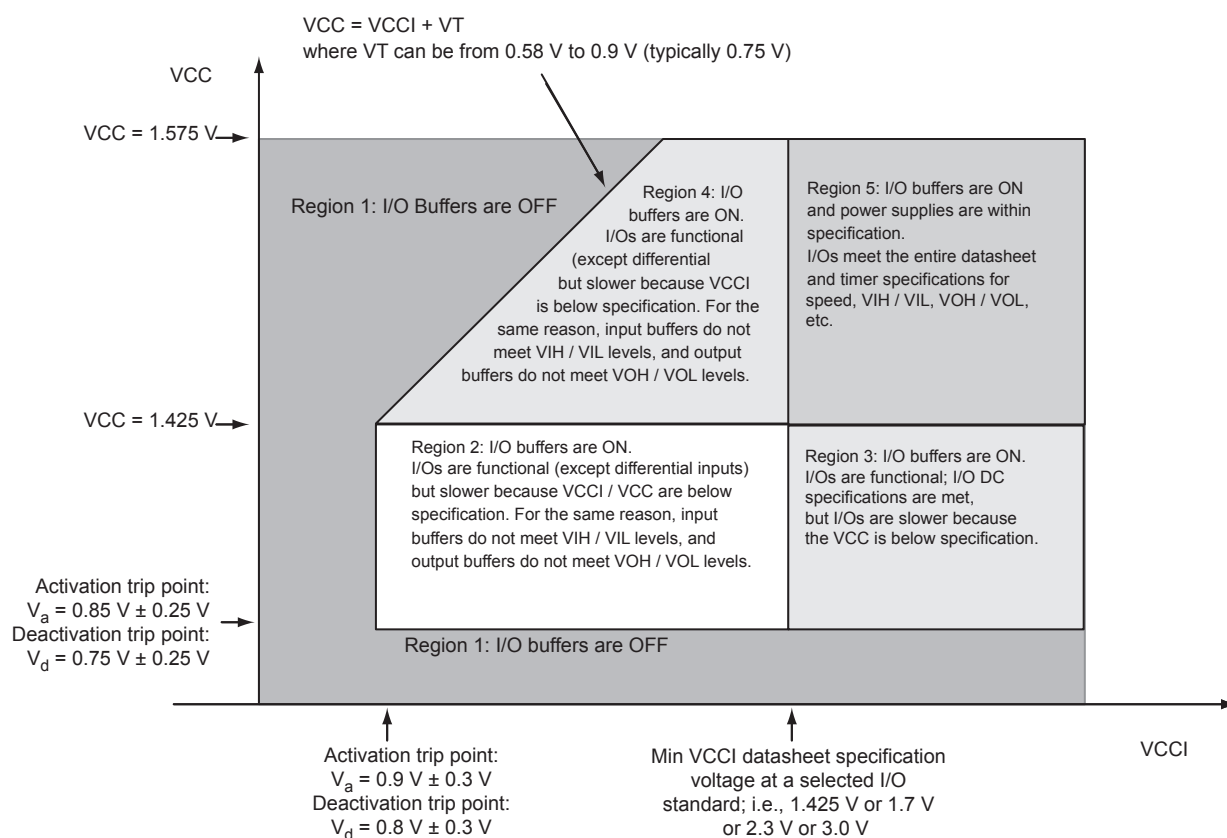


Figure 2-1 • I/O State as a Function of VCCI and VCC Voltage Levels

Power Calculation Methodology

This section describes a simplified method to estimate power consumption of an application. For more accurate and detailed power estimations, use the SmartPower tool in the Libero SoC software.

The power calculation methodology described below uses the following variables:

- The number of PLLs as well as the number and the frequency of each output clock generated
- The number of combinatorial and sequential cells used in the design
- The internal clock frequencies
- The number and the standard of I/O pins used in the design
- The number of RAM blocks used in the design
- Toggle rates of I/O pins as well as VersaTiles—guidelines are provided in [Table 2-11 on page 2-11](#).
- Enable rates of output buffers—guidelines are provided for typical applications in [Table 2-12 on page 2-11](#).
- Read rate and write rate to the memory—guidelines are provided for typical applications in [Table 2-12 on page 2-11](#). The calculation should be repeated for each clock domain defined in the design.

Methodology

Total Power Consumption— P_{TOTAL}

$$P_{TOTAL} = P_{STAT} + P_{DYN}$$

P_{STAT} is the total static power consumption.

P_{DYN} is the total dynamic power consumption.

Total Static Power Consumption— P_{STAT}

$$P_{STAT} = PDC1 + N_{INPUTS} * PDC2 + N_{OUTPUTS} * PDC3$$

N_{INPUTS} is the number of I/O input buffers used in the design.

$N_{OUTPUTS}$ is the number of I/O output buffers used in the design.

Total Dynamic Power Consumption— P_{DYN}

$$P_{DYN} = P_{CLOCK} + P_{S-CELL} + P_{C-CELL} + P_{NET} + P_{INPUTS} + P_{OUTPUTS} + P_{MEMORY} + P_{PLL}$$

Global Clock Contribution— P_{CLOCK}

$$P_{CLOCK} = (PAC1 + N_{SPINE} * PAC2 + N_{ROW} * PAC3 + N_{S-CELL} * PAC4) * F_{CLK}$$

N_{SPINE} is the number of global spines used in the user design—guidelines are provided in the "Spine Architecture" section of the Global Resources chapter in the [ProASIC3E FPGA Fabric User's Guide](#).

N_{ROW} is the number of VersaTile rows used in the design—guidelines are provided in the "Spine Architecture" section of the Global Resources chapter in the [ProASIC3E FPGA Fabric User's Guide](#).

F_{CLK} is the global clock signal frequency.

N_{S-CELL} is the number of VersaTiles used as sequential modules in the design.

PAC1, PAC2, PAC3, and PAC4 are device-dependent.

Sequential Cells Contribution— P_{S-CELL}

$$P_{S-CELL} = N_{S-CELL} * (PAC5 + \alpha_1 / 2 * PAC6) * F_{CLK}$$

N_{S-CELL} is the number of VersaTiles used as sequential modules in the design. When a multi-tile sequential cell is used, it should be accounted for as 1.

α_1 is the toggle rate of VersaTile outputs—guidelines are provided in [Table 2-11 on page 2-11](#).

F_{CLK} is the global clock signal frequency.

Table 2-14 • Summary of Maximum and Minimum DC Input Levels
Applicable to Commercial and Industrial Conditions

| DC I/O Standards | Commercial ¹ | | Industrial ² | |
|-----------------------------|-------------------------|------------------|-------------------------|------------------|
| | IIL ³ | IIH ⁴ | IIL ³ | IIH ⁴ |
| | μA | μA | μA | μA |
| 3.3 V LVTTTL / 3.3 V LVCMOS | 10 | 10 | 15 | 15 |
| 3.3 V LVCMOS Wide Range | 10 | 10 | 15 | 15 |
| 2.5 V LVCMOS | 10 | 10 | 15 | 15 |
| 1.8 V LVCMOS | 10 | 10 | 15 | 15 |
| 1.5 V LVCMOS | 10 | 10 | 15 | 15 |
| 3.3 V PCI | 10 | 10 | 15 | 15 |
| 3.3 V PCI-X | 10 | 10 | 15 | 15 |
| 3.3 V GTL | 10 | 10 | 15 | 15 |
| 2.5 V GTL | 10 | 10 | 15 | 15 |
| 3.3 V GTL+ | 10 | 10 | 15 | 15 |
| 2.5 V GTL+ | 10 | 10 | 15 | 15 |
| HSTL (I) | 10 | 10 | 15 | 15 |
| HSTL (II) | 10 | 10 | 15 | 15 |
| SSTL2 (I) | 10 | 10 | 15 | 15 |
| SSTL2 (II) | 10 | 10 | 15 | 15 |
| SSTL3 (I) | 10 | 10 | 15 | 15 |
| SSTL3 (II) | 10 | 10 | 15 | 15 |

Notes:

1. Commercial range ($0^{\circ}\text{C} < T_A < 70^{\circ}\text{C}$)
2. Industrial range ($-40^{\circ}\text{C} < T_A < 85^{\circ}\text{C}$)
3. IIL is the input leakage current per I/O pin over recommended operation conditions where $-0.3\text{ V} < V_{IN} < V_{IL}$.
4. IIH is the input leakage current per I/O pin over recommended operating conditions $V_{IH} < V_{IN} < V_{CCI}$. Input current is larger when operating outside recommended ranges.

Table 2-36 • 2.5 V LVCMOS Low Slew

Commercial-Case Conditions: $T_J = 70^{\circ}\text{C}$, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V

| Drive Strength | Speed Grade | t_{DOUT} | t_{DP} | t_{DIN} | t_{PY} | t_{PYS} | t_{EOUT} | t_{ZL} | t_{ZH} | t_{LZ} | t_{HZ} | t_{ZLS} | t_{ZHS} | Units |
|----------------|-------------|------------|----------|-----------|----------|-----------|------------|----------|----------|----------|----------|-----------|-----------|-------|
| 4 mA | Std. | 0.66 | 12.00 | 0.04 | 1.51 | 1.66 | 0.43 | 12.23 | 11.61 | 2.72 | 2.20 | 14.46 | 13.85 | ns |
| | –1 | 0.56 | 10.21 | 0.04 | 1.29 | 1.41 | 0.36 | 10.40 | 9.88 | 2.31 | 1.87 | 12.30 | 11.78 | ns |
| | –2 | 0.49 | 8.96 | 0.03 | 1.13 | 1.24 | 0.32 | 9.13 | 8.67 | 2.03 | 1.64 | 10.80 | 10.34 | ns |
| 8 mA | Std. | 0.66 | 8.73 | 0.04 | 1.51 | 1.66 | 0.43 | 8.89 | 8.01 | 3.10 | 2.93 | 11.13 | 10.25 | ns |
| | –1 | 0.56 | 7.43 | 0.04 | 1.29 | 1.41 | 0.36 | 7.57 | 6.82 | 2.64 | 2.49 | 9.47 | 8.72 | ns |
| | –2 | 0.49 | 6.52 | 0.03 | 1.13 | 1.24 | 0.32 | 6.64 | 5.98 | 2.32 | 2.19 | 8.31 | 7.65 | ns |
| 12 mA | Std. | 0.66 | 6.77 | 0.04 | 1.51 | 1.66 | 0.43 | 6.90 | 6.11 | 3.37 | 3.39 | 9.14 | 8.34 | ns |
| | –1 | 0.56 | 5.76 | 0.04 | 1.29 | 1.41 | 0.36 | 5.87 | 5.20 | 2.86 | 2.89 | 7.77 | 7.10 | ns |
| | –2 | 0.49 | 5.06 | 0.03 | 1.13 | 1.24 | 0.32 | 5.15 | 4.56 | 2.51 | 2.53 | 6.82 | 6.23 | ns |
| 16 mA | Std. | 0.66 | 6.31 | 0.04 | 1.51 | 1.66 | 0.43 | 6.42 | 5.73 | 3.42 | 3.52 | 8.66 | 7.96 | ns |
| | –1 | 0.56 | 5.37 | 0.04 | 1.29 | 1.41 | 0.36 | 5.46 | 4.87 | 2.91 | 3.00 | 7.37 | 6.77 | ns |
| | –2 | 0.49 | 4.71 | 0.03 | 1.13 | 1.24 | 0.32 | 4.80 | 4.28 | 2.56 | 2.63 | 6.47 | 5.95 | ns |
| 24 mA | Std. | 0.66 | 5.93 | 0.04 | 1.51 | 1.66 | 0.43 | 6.04 | 5.70 | 3.49 | 4.00 | 8.28 | 7.94 | ns |
| | –1 | 0.56 | 5.05 | 0.04 | 1.29 | 1.41 | 0.36 | 5.14 | 4.85 | 2.97 | 3.40 | 7.04 | 6.75 | ns |
| | –2 | 0.49 | 4.43 | 0.03 | 1.13 | 1.24 | 0.32 | 4.51 | 4.26 | 2.61 | 2.99 | 6.18 | 5.93 | ns |

Note: For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-5](#) for derating values.

Voltage-Referenced I/O Characteristics

3.3 V GTL

Gunning Transceiver Logic is a high-speed bus standard (JESD8-3). It provides a differential amplifier input buffer and an open-drain output buffer. The VCCI pin should be connected to 3.3 V.

Table 2-48 • Minimum and Maximum DC Input and Output Levels

| 3.3 V GTL | VIL | | VIH | | VOL | VOH | IOL | IOH | IOSL | IOSH | IIL | IIH |
|--------------------|--------|-------------|-------------|--------|--------|--------|-----|-----|----------------------|----------------------|-----------------|-----------------|
| Drive Strength | Min. V | Max. V | Min. V | Max. V | Max. V | Min. V | mA | mA | Max. mA ¹ | Max. mA ¹ | μA ² | μA ² |
| 20 mA ³ | −0.3 | VREF − 0.05 | VREF + 0.05 | 3.6 | 0.4 | − | 20 | 20 | 181 | 268 | 10 | 10 |

Notes:

1. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
2. Currents are measured at 85°C junction temperature.
3. Output drive strength is below JEDEC specification.

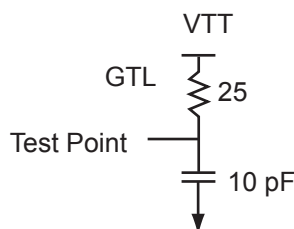


Figure 2-12 • AC Loading

Table 2-49 • AC Waveforms, Measuring Points, and Capacitive Loads

| Input Low (V) | Input High (V) | Measuring Point* (V) | VREF (typ.) (V) | VTT (typ.) (V) | C _{LOAD} (pF) |
|---------------|----------------|----------------------|-----------------|----------------|------------------------|
| VREF − 0.05 | VREF + 0.05 | 0.8 | 0.8 | 1.2 | 10 |

Note: *Measuring point = V_{trip}. See [Table 2-15 on page 2-18](#) for a complete table of trip points.

Timing Characteristics

Table 2-50 • 3.3 V GTL

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V,
Worst-Case VCCI = 3.0 V VREF = 0.8 V

| Speed Grade | t _{DOUT} | t _{DP} | t _{DIN} | t _{PY} | t _{EOUT} | t _{ZL} | t _{ZH} | t _{LZ} | t _{HZ} | t _{ZLS} | t _{ZHS} | Units |
|-------------|-------------------|-----------------|------------------|-----------------|-------------------|-----------------|-----------------|-----------------|-----------------|------------------|------------------|-------|
| Std. | 0.60 | 2.08 | 0.04 | 2.93 | 0.43 | 2.04 | 2.08 | | | 4.27 | 4.31 | ns |
| −1 | 0.51 | 1.77 | 0.04 | 2.50 | 0.36 | 1.73 | 1.77 | | | 3.63 | 3.67 | ns |
| −2 | 0.45 | 1.55 | 0.03 | 2.19 | 0.32 | 1.52 | 1.55 | | | 3.19 | 3.22 | ns |

Note: For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-5](#) for derating values.

2.5 V GTL

Gunning Transceiver Logic is a high-speed bus standard (JESD8-3). It provides a differential amplifier input buffer and an open-drain output buffer. The VCCI pin should be connected to 2.5 V.

Table 2-51 • Minimum and Maximum DC Input and Output Levels

| 2.5 GTL | VIL | | VIH | | VOL | VOH | IOL | IOH | IOSL | IOSH | IIL | IIH |
|--------------------|---------|-------------|-------------|--------|--------|--------|-----|-----|----------------------|----------------------|-----------------|-----------------|
| Drive Strength | Min., V | Max. V | Min. V | Max. V | Max. V | Min. V | mA | mA | Max. mA ¹ | Max. mA ¹ | μA ² | μA ² |
| 20 mA ³ | −0.3 | VREF − 0.05 | VREF + 0.05 | 3.6 | 0.4 | − | 20 | 20 | 124 | 169 | 10 | 10 |

Notes:

1. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
2. Currents are measured at 85°C junction temperature.
3. Output drive strength is below JEDEC specification.

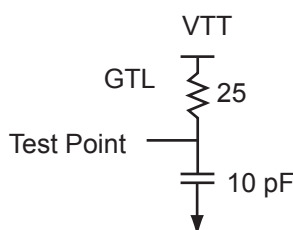


Figure 2-13 • AC Loading

Table 2-52 • AC Waveforms, Measuring Points, and Capacitive Loads

| Input Low (V) | Input High (V) | Measuring Point* (V) | VREF (typ.) (V) | VTT (typ.) (V) | C _{LOAD} (pF) |
|---------------|----------------|----------------------|-----------------|----------------|------------------------|
| VREF − 0.05 | VREF + 0.05 | 0.8 | 0.8 | 1.2 | 10 |

Note: *Measuring point = Vtrip. See [Table 2-15 on page 2-18](#) for a complete table of trip points.

Timing Characteristics

Table 2-53 • 2.5 V GTL

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V,
Worst-Case VCCI = 3.0 V VREF = 0.8 V

| Speed Grade | t _{DOUT} | t _{DP} | t _{DIN} | t _{PY} | t _{EOUT} | t _{ZL} | t _{ZH} | t _{LZ} | t _{HZ} | t _{ZLS} | t _{ZHS} | Units |
|-------------|-------------------|-----------------|------------------|-----------------|-------------------|-----------------|-----------------|-----------------|-----------------|------------------|------------------|-------|
| Std. | 0.60 | 2.13 | 0.04 | 2.46 | 0.43 | 2.16 | 2.13 | | | 4.40 | 4.36 | ns |
| −1 | 0.51 | 1.81 | 0.04 | 2.09 | 0.36 | 1.84 | 1.81 | | | 3.74 | 3.71 | ns |
| −2 | 0.45 | 1.59 | 0.03 | 1.83 | 0.32 | 1.61 | 1.59 | | | 3.28 | 3.26 | ns |

Note: For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-5](#) for derating values.

SSTL2 Class I

Stub-Speed Terminated Logic for 2.5 V memory bus standard (JESD8-9). ProASIC3E devices support Class I. This provides a differential amplifier input buffer and a push-pull output buffer.

Table 2-66 • Minimum and Maximum DC Input and Output Levels

| SSTL2 Class I | VIL | | VIH | | VOL | VOH | IOL | IOH | IOSL | IOSH | IIL | IIH |
|----------------|--------|------------|------------|--------|--------|-------------|-----|-----|----------------------|----------------------|-----------------|-----------------|
| Drive Strength | Min. V | Max. V | Min. V | Max. V | Max. V | Min. V | mA | mA | Max. mA ¹ | Max. mA ¹ | μA ² | μA ² |
| 15 mA | -0.3 | VREF - 0.2 | VREF + 0.2 | 3.6 | 0.54 | VCCI - 0.62 | 15 | 15 | 87 | 83 | 10 | 10 |

Notes:

1. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
2. Currents are measured at 85°C junction temperature.

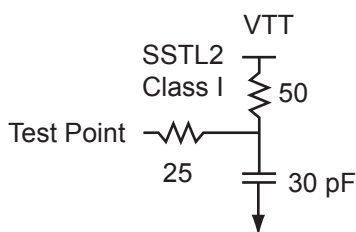


Figure 2-18 • AC Loading

Table 2-67 • AC Waveforms, Measuring Points, and Capacitive Loads

| Input Low (V) | Input High (V) | Measuring Point* (V) | VREF (typ.) (V) | VTT (typ.) (V) | C _{LOAD} (pF) |
|---------------|----------------|----------------------|-----------------|----------------|------------------------|
| VREF - 0.2 | VREF + 0.2 | 1.25 | 1.25 | 1.25 | 30 |

Note: *Measuring point = Vtrip. See Table 2-15 on page 2-18 for a complete table of trip points.

Timing Characteristics

Table 2-68 • SSTL 2 Class I

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V,
Worst-Case VCCI = 2.3 V, VREF = 1.25 V

| Speed Grade | t _{DOUT} | t _{DP} | t _{DIN} | t _{PY} | t _{EOUT} | t _{ZL} | t _{ZH} | t _{LZ} | t _{HZ} | t _{ZLS} | t _{ZHS} | Units |
|-------------|-------------------|-----------------|------------------|-----------------|-------------------|-----------------|-----------------|-----------------|-----------------|------------------|------------------|-------|
| Std. | 0.66 | 2.13 | 0.04 | 1.33 | 0.43 | 2.17 | 1.85 | | | 4.40 | 4.08 | ns |
| -1 | 0.56 | 1.81 | 0.04 | 1.14 | 0.36 | 1.84 | 1.57 | | | 3.74 | 3.47 | ns |
| -2 | 0.49 | 1.59 | 0.03 | 1.00 | 0.32 | 1.62 | 1.38 | | | 3.29 | 3.05 | ns |

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-5 for derating values.

Differential I/O Characteristics

Physical Implementation

Configuration of the I/O modules as a differential pair is handled by the Designer software when the user instantiates a differential I/O macro in the design.

Differential I/Os can also be used in conjunction with the embedded Input Register (InReg), Output Register (OutReg), Enable Register (EnReg), and DDR. However, there is no support for bidirectional I/Os or tristates with the LVPECL standards.

LVDS

Low-Voltage Differential Signaling (ANSI/TIA/EIA-644) is a high-speed, differential I/O standard. It requires that one data bit be carried through two signal lines, so two pins are needed. It also requires external resistor termination.

The full implementation of the LVDS transmitter and receiver is shown in an example in [Figure 2-22](#). The building blocks of the LVDS transmitter-receiver are one transmitter macro, one receiver macro, three board resistors at the transmitter end, and one resistor at the receiver end. The values for the three driver resistors are different from those used in the LVPECL implementation because the output standard specifications are different.

Along with LVDS I/O, ProASIC3E also supports Bus LVDS structure and Multipoint LVDS (M-LVDS) configuration (up to 40 nodes).

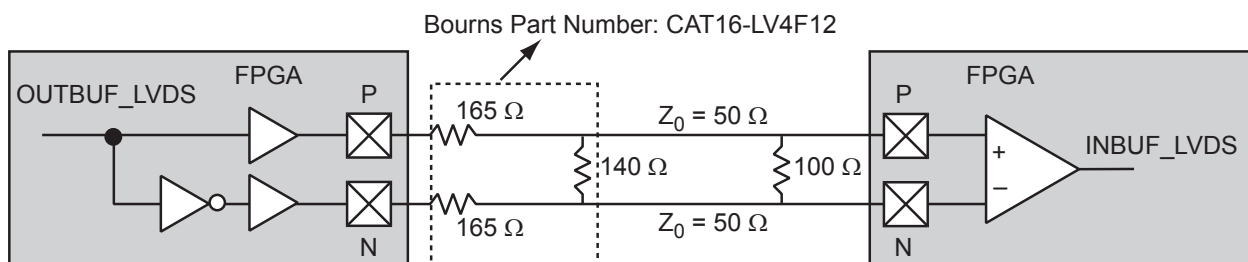


Figure 2-22 • LVDS Circuit Diagram and Board-Level Implementation

Table 2-84 • Parameter Definition and Measuring Nodes

| Parameter Name | Parameter Definition | Measuring Nodes (from, to)* |
|----------------|--|-----------------------------|
| t_{OCLKQ} | Clock-to-Q of the Output Data Register | H, DOUT |
| t_{OSUD} | Data Setup Time for the Output Data Register | F, H |
| t_{OHD} | Data Hold Time for the Output Data Register | F, H |
| t_{OSUE} | Enable Setup Time for the Output Data Register | G, H |
| t_{OHE} | Enable Hold Time for the Output Data Register | G, H |
| t_{OPRE2Q} | Asynchronous Preset-to-Q of the Output Data Register | L, DOUT |
| $t_{OREMPRE}$ | Asynchronous Preset Removal Time for the Output Data Register | L, H |
| $t_{ORECPRE}$ | Asynchronous Preset Recovery Time for the Output Data Register | L, H |
| t_{OECLKQ} | Clock-to-Q of the Output Enable Register | H, EOUT |
| t_{OESUD} | Data Setup Time for the Output Enable Register | J, H |
| t_{OEHD} | Data Hold Time for the Output Enable Register | J, H |
| t_{OESUE} | Enable Setup Time for the Output Enable Register | K, H |
| t_{OEHE} | Enable Hold Time for the Output Enable Register | K, H |
| $t_{OEPRE2Q}$ | Asynchronous Preset-to-Q of the Output Enable Register | I, EOUT |
| $t_{OEREMPRE}$ | Asynchronous Preset Removal Time for the Output Enable Register | I, H |
| $t_{OERECPRE}$ | Asynchronous Preset Recovery Time for the Output Enable Register | I, H |
| t_{ICLKQ} | Clock-to-Q of the Input Data Register | A, E |
| t_{ISUD} | Data Setup Time for the Input Data Register | C, A |
| t_{IHD} | Data Hold Time for the Input Data Register | C, A |
| t_{ISUE} | Enable Setup Time for the Input Data Register | B, A |
| t_{IHE} | Enable Hold Time for the Input Data Register | B, A |
| t_{IPRE2Q} | Asynchronous Preset-to-Q of the Input Data Register | D, E |
| $t_{IREMPRE}$ | Asynchronous Preset Removal Time for the Input Data Register | D, A |
| $t_{IRECPRE}$ | Asynchronous Preset Recovery Time for the Input Data Register | D, A |

Note: *See Figure 2-25 on page 2-53 for more information.

Output Enable Register

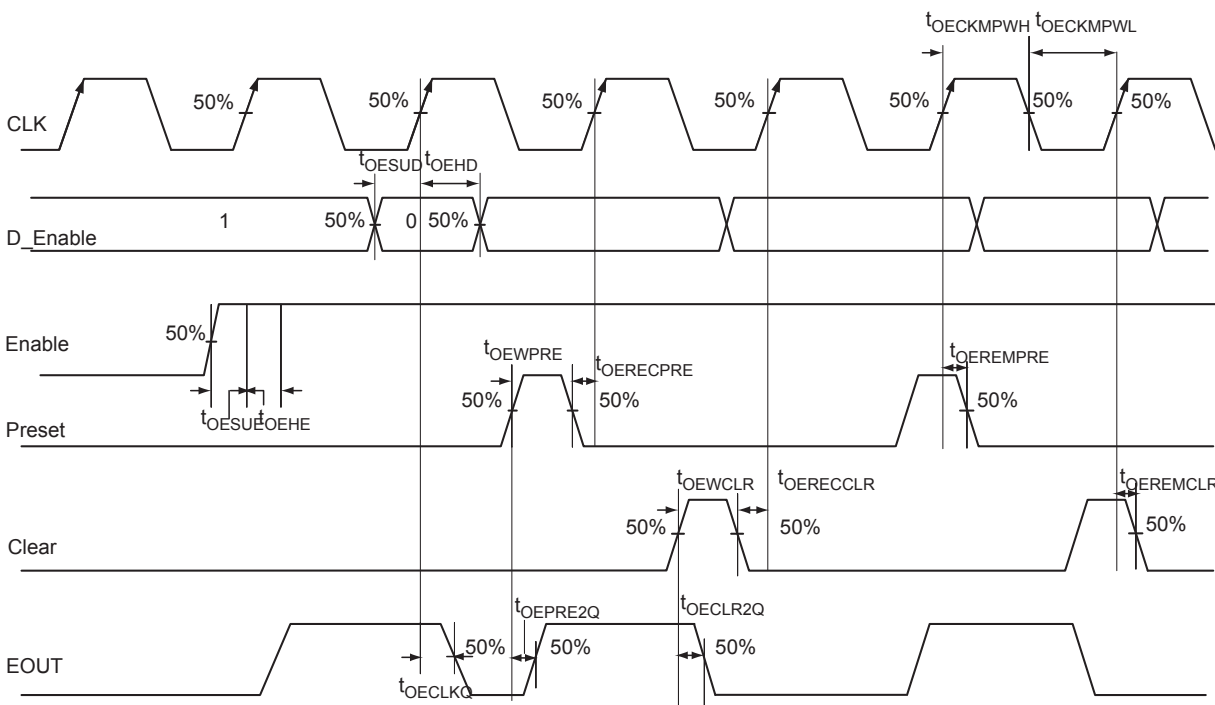


Figure 2-29 • Output Enable Register Timing Diagram

Timing Characteristics

Table 2-88 • Output Enable Register Propagation Delays

Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, Worst-Case $V_{CC} = 1.425\text{ V}$

| Parameter | Description | -2 | -1 | Std. | Units |
|----------------|--|------|------|------|-------|
| t_{OECLKQ} | Clock-to-Q of the Output Enable Register | 0.59 | 0.67 | 0.79 | ns |
| t_{OESUD} | Data Setup Time for the Output Enable Register | 0.31 | 0.36 | 0.42 | ns |
| t_{OEHD} | Data Hold Time for the Output Enable Register | 0.00 | 0.00 | 0.00 | ns |
| t_{OESUE} | Enable Setup Time for the Output Enable Register | 0.44 | 0.50 | 0.58 | ns |
| t_{OEHE} | Enable Hold Time for the Output Enable Register | 0.00 | 0.00 | 0.00 | ns |
| $t_{OECLR2Q}$ | Asynchronous Clear-to-Q of the Output Enable Register | 0.67 | 0.76 | 0.89 | ns |
| $t_{OEPRE2Q}$ | Asynchronous Preset-to-Q of the Output Enable Register | 0.67 | 0.76 | 0.89 | ns |
| $t_{OEREMCLR}$ | Asynchronous Clear Removal Time for the Output Enable Register | 0.00 | 0.00 | 0.00 | ns |
| $t_{OERECCLR}$ | Asynchronous Clear Recovery Time for the Output Enable Register | 0.22 | 0.25 | 0.30 | ns |
| $t_{OEREMPRE}$ | Asynchronous Preset Removal Time for the Output Enable Register | 0.00 | 0.00 | 0.00 | ns |
| $t_{OERECPRE}$ | Asynchronous Preset Recovery Time for the Output Enable Register | 0.22 | 0.25 | 0.30 | ns |
| t_{OEWCLR} | Asynchronous Clear Minimum Pulse Width for the Output Enable Register | 0.22 | 0.25 | 0.30 | ns |
| t_{OEWPRE} | Asynchronous Preset Minimum Pulse Width for the Output Enable Register | 0.22 | 0.25 | 0.30 | ns |
| $t_{OECKMPWH}$ | Clock Minimum Pulse Width High for the Output Enable Register | 0.36 | 0.41 | 0.48 | ns |
| $t_{OECKMPWL}$ | Clock Minimum Pulse Width Low for the Output Enable Register | 0.32 | 0.37 | 0.43 | ns |

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-5 for derating values.

Timing Characteristics

Table 2-93 • Combinatorial Cell Propagation Delays
Commercial-Case Conditions: $T_J = 70^\circ\text{C}$, Worst-Case $V_{CC} = 1.425\text{ V}$

| Combinatorial Cell | Equation | Parameter | -2 | -1 | Std. | Units |
|--------------------|-----------------------------------|-----------|------|------|------|-------|
| INV | $Y = !A$ | t_{PD} | 0.40 | 0.46 | 0.54 | ns |
| AND2 | $Y = A \cdot B$ | t_{PD} | 0.47 | 0.54 | 0.63 | ns |
| NAND2 | $Y = !(A \cdot B)$ | t_{PD} | 0.47 | 0.54 | 0.63 | ns |
| OR2 | $Y = A + B$ | t_{PD} | 0.49 | 0.55 | 0.65 | ns |
| NOR2 | $Y = !(A + B)$ | t_{PD} | 0.49 | 0.55 | 0.65 | ns |
| XOR2 | $Y = A \oplus B$ | t_{PD} | 0.74 | 0.84 | 0.99 | ns |
| MAJ3 | $Y = \text{MAJ}(A, B, C)$ | t_{PD} | 0.70 | 0.79 | 0.93 | ns |
| XOR3 | $Y = A \oplus B \oplus C$ | t_{PD} | 0.87 | 1.00 | 1.17 | ns |
| MUX2 | $Y = A \text{ IS } + B \text{ S}$ | t_{PD} | 0.51 | 0.58 | 0.68 | ns |
| AND3 | $Y = A \cdot B \cdot C$ | t_{PD} | 0.56 | 0.64 | 0.75 | ns |

Note: For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-5](#) for derating values.

VersaTile Specifications as a Sequential Module

The ProASIC3E library offers a wide variety of sequential cells, including flip-flops and latches. Each has a data input and optional enable, clear, or preset. In this section, timing characteristics are presented for a representative sample from the library. For more details, refer to the [Fusion](#), [IGLOO/e](#), and [ProASIC3/E Macro Library Guide](#).

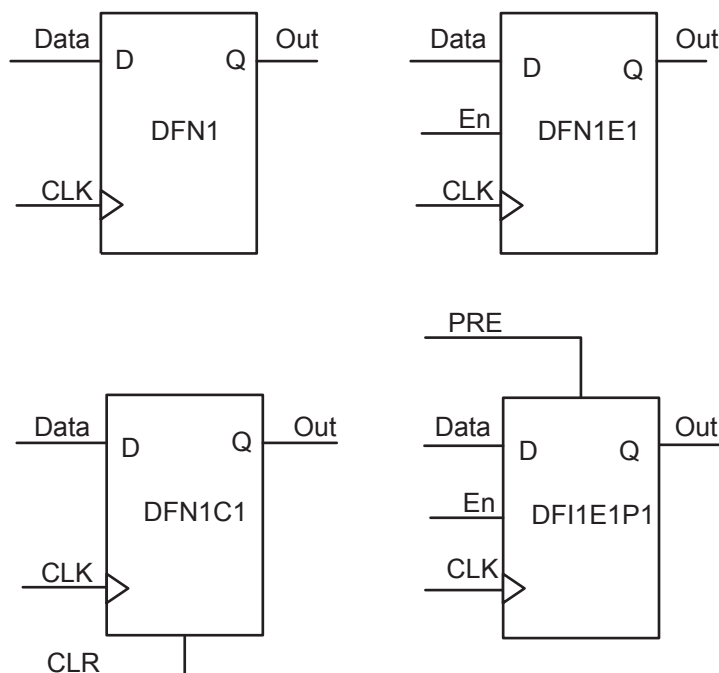


Figure 2-36 • Sample of Sequential Cells

Clock Conditioning Circuits

CCC Electrical Specifications

Timing Characteristics

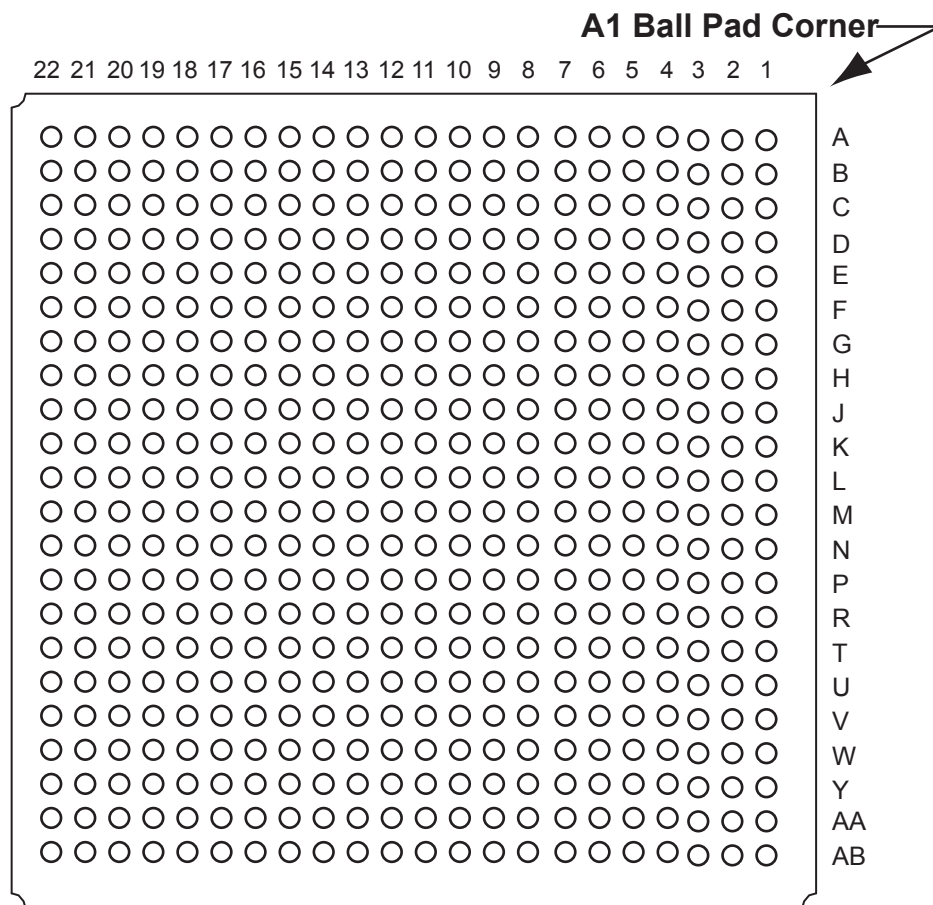
Table 2-98 • ProASIC3E CCC/PLL Specification

| Parameter | Minimum | Typical | Maximum | Units |
|--|--------------------------------|------------------|------------------------|-------|
| Clock Conditioning Circuitry Input Frequency f_{IN_CCC} | 1.5 | | 350 | MHz |
| Clock Conditioning Circuitry Output Frequency f_{OUT_CCC} | 0.75 | | 350 | MHz |
| Delay Increments in Programmable Delay Blocks ^{1, 2} | | 160 ³ | | ps |
| Serial Clock (SCLK) for Dynamic PLL ⁴ | | | 125 | MHz |
| Number of Programmable Values in Each Programmable Delay Block | | | 32 | |
| Input Period Jitter | | | 1.5 | ns |
| CCC Output Peak-to-Peak Period Jitter F_{CCC_OUT} | Max Peak-to-Peak Period Jitter | | | |
| | 1 Global Network Used | | 3 Global Networks Used | |
| 0.75 MHz to 24 MHz | 0.50% | | 0.70% | |
| 24 MHz to 100 MHz | 1.00% | | 1.20% | |
| 100 MHz to 250 MHz | 1.75% | | 2.00% | |
| 250 MHz to 350 MHz | 2.50% | | 5.60% | |
| Acquisition Time | LockControl = 0 | | 300 | μs |
| | LockControl = 1 | | 6.0 | ms |
| Tracking Jitter ⁵ | LockControl = 0 | | 1.6 | ns |
| | LockControl = 1 | | 0.8 | ns |
| Output Duty Cycle | 48.5 | | 51.5 | % |
| Delay Range in Block: Programmable Delay 1 ^{1, 2} | 0.6 | | 5.56 | ns |
| Delay Range in Block: Programmable Delay 2 ^{1, 2} | 0.025 | | 5.56 | ns |
| Delay Range in Block: Fixed Delay ^{1, 4} | | 2.2 | | ns |

Notes:

1. This delay is a function of voltage and temperature. See [Table 2-6 on page 2-5](#) for deratings
2. $T_J = 25^\circ\text{C}$, $V_{CC} = 1.5\text{ V}$.
3. When the CCC/PLL core is generated by Microsemi core generator software, not all delay values of the specified delay increments are available. Refer to the Libero SoC Online Help for more information.
4. Maximum value obtained for a –2 speed-grade device in worst-case commercial conditions. For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-5](#) for derating values.
5. Tracking jitter is defined as the variation in clock edge position of PLL outputs with reference to the PLL input clock edge. Tracking jitter does not measure the variation in PLL output period, which is covered by the period jitter parameter.

FG484



Note: This is the bottom view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at <http://www.microsemi.com/products/fpga-soc/solutions>.

| FG484 | |
|------------|------------------|
| Pin Number | A3PE600 Function |
| A1 | GND |
| A2 | GND |
| A3 | VCCIB0 |
| A4 | IO06NDB0V1 |
| A5 | IO06PDB0V1 |
| A6 | IO08NDB0V1 |
| A7 | IO08PDB0V1 |
| A8 | IO11PDB0V1 |
| A9 | IO17PDB0V2 |
| A10 | IO18NDB0V2 |
| A11 | IO18PDB0V2 |
| A12 | IO22PDB1V0 |
| A13 | IO26PDB1V0 |
| A14 | IO29NDB1V1 |
| A15 | IO29PDB1V1 |
| A16 | IO31NDB1V1 |
| A17 | IO31PDB1V1 |
| A18 | IO32NDB1V1 |
| A19 | NC |
| A20 | VCCIB1 |
| A21 | GND |
| A22 | GND |
| AA1 | GND |
| AA2 | VCCIB6 |
| AA3 | NC |
| AA4 | IO98PDB5V2 |
| AA5 | IO96NDB5V2 |
| AA6 | IO96PDB5V2 |
| AA7 | IO86NDB5V0 |
| AA8 | IO86PDB5V0 |
| AA9 | IO85PDB5V0 |
| AA10 | IO85NDB5V0 |
| AA11 | IO78PPB4V1 |
| AA12 | IO79NDB4V1 |
| AA13 | IO79PDB4V1 |
| AA14 | NC |

| FG484 | |
|------------|------------------|
| Pin Number | A3PE600 Function |
| AA15 | NC |
| AA16 | IO71NDB4V0 |
| AA17 | IO71PDB4V0 |
| AA18 | NC |
| AA19 | NC |
| AA20 | NC |
| AA21 | VCCIB3 |
| AA22 | GND |
| AB1 | GND |
| AB2 | GND |
| AB3 | VCCIB5 |
| AB4 | IO97NDB5V2 |
| AB5 | IO97PDB5V2 |
| AB6 | IO93NDB5V1 |
| AB7 | IO93PDB5V1 |
| AB8 | IO87NDB5V0 |
| AB9 | IO87PDB5V0 |
| AB10 | NC |
| AB11 | NC |
| AB12 | IO75NDB4V1 |
| AB13 | IO75PDB4V1 |
| AB14 | IO72NDB4V0 |
| AB15 | IO72PDB4V0 |
| AB16 | IO73NDB4V0 |
| AB17 | IO73PDB4V0 |
| AB18 | NC |
| AB19 | NC |
| AB20 | VCCIB4 |
| AB21 | GND |
| AB22 | GND |
| B1 | GND |
| B2 | VCCIB7 |
| B3 | NC |
| B4 | IO03NDB0V0 |
| B5 | IO03PDB0V0 |
| B6 | IO07NDB0V1 |

| FG484 | |
|------------|------------------|
| Pin Number | A3PE600 Function |
| B7 | IO07PDB0V1 |
| B8 | IO11NDB0V1 |
| B9 | IO17NDB0V2 |
| B10 | IO14PDB0V2 |
| B11 | IO19PDB0V2 |
| B12 | IO22NDB1V0 |
| B13 | IO26NDB1V0 |
| B14 | NC |
| B15 | NC |
| B16 | IO30NDB1V1 |
| B17 | IO30PDB1V1 |
| B18 | IO32PDB1V1 |
| B19 | NC |
| B20 | NC |
| B21 | VCCIB2 |
| B22 | GND |
| C1 | VCCIB7 |
| C2 | NC |
| C3 | NC |
| C4 | NC |
| C5 | GND |
| C6 | IO04NDB0V0 |
| C7 | IO04PDB0V0 |
| C8 | VCC |
| C9 | VCC |
| C10 | IO14NDB0V2 |
| C11 | IO19NDB0V2 |
| C12 | NC |
| C13 | NC |
| C14 | VCC |
| C15 | VCC |
| C16 | NC |
| C17 | NC |
| C18 | GND |
| C19 | NC |
| C20 | NC |

| FG484 | |
|------------|------------------|
| Pin Number | A3PE600 Function |
| H19 | IO41PDB2V0 |
| H20 | VCC |
| H21 | NC |
| H22 | NC |
| J1 | IO123NDB7V0 |
| J2 | IO123PDB7V0 |
| J3 | NC |
| J4 | IO124PDB7V0 |
| J5 | IO125PDB7V0 |
| J6 | IO126PDB7V0 |
| J7 | IO130NDB7V1 |
| J8 | VCCIB7 |
| J9 | GND |
| J10 | VCC |
| J11 | VCC |
| J12 | VCC |
| J13 | VCC |
| J14 | GND |
| J15 | VCCIB2 |
| J16 | IO38NDB2V0 |
| J17 | IO40NDB2V0 |
| J18 | IO40PDB2V0 |
| J19 | IO45PPB2V1 |
| J20 | NC |
| J21 | IO48PDB2V1 |
| J22 | IO46PDB2V1 |
| K1 | IO121NDB7V0 |
| K2 | IO121PDB7V0 |
| K3 | NC |
| K4 | IO124NDB7V0 |
| K5 | IO125NDB7V0 |
| K6 | IO126NDB7V0 |
| K7 | GFC1/IO120PPB7V0 |
| K8 | VCCIB7 |
| K9 | VCC |
| K10 | GND |

| FG484 | |
|------------|------------------|
| Pin Number | A3PE600 Function |
| K11 | GND |
| K12 | GND |
| K13 | GND |
| K14 | VCC |
| K15 | VCCIB2 |
| K16 | GCC1/IO50PPB2V1 |
| K17 | IO44NDB2V1 |
| K18 | IO44PDB2V1 |
| K19 | IO49NPB2V1 |
| K20 | IO45NPB2V1 |
| K21 | IO48NDB2V1 |
| K22 | IO46NDB2V1 |
| L1 | NC |
| L2 | IO122PDB7V0 |
| L3 | IO122NDB7V0 |
| L4 | GFB0/IO119NPB7V0 |
| L5 | GFA0/IO118NDB6V1 |
| L6 | GFB1/IO119PPB7V0 |
| L7 | VCOMPLF |
| L8 | GFC0/IO120NPB7V0 |
| L9 | VCC |
| L10 | GND |
| L11 | GND |
| L12 | GND |
| L13 | GND |
| L14 | VCC |
| L15 | GCC0/IO50NPB2V1 |
| L16 | GCB1/IO51PPB2V1 |
| L17 | GCA0/IO52NPB3V0 |
| L18 | VCOMPLC |
| L19 | GCB0/IO51NPB2V1 |
| L20 | IO49PPB2V1 |
| L21 | IO47NDB2V1 |
| L22 | IO47PDB2V1 |
| M1 | NC |
| M2 | IO114NPB6V1 |

| FG484 | |
|------------|------------------|
| Pin Number | A3PE600 Function |
| M3 | IO117NDB6V1 |
| M4 | GFA2/IO117PDB6V1 |
| M5 | GFA1/IO118PDB6V1 |
| M6 | VCCPLF |
| M7 | IO116NDB6V1 |
| M8 | GFB2/IO116PDB6V1 |
| M9 | VCC |
| M10 | GND |
| M11 | GND |
| M12 | GND |
| M13 | GND |
| M14 | VCC |
| M15 | GCB2/IO54PPB3V0 |
| M16 | GCA1/IO52PPB3V0 |
| M17 | GCC2/IO55PPB3V0 |
| M18 | VCCPLC |
| M19 | GCA2/IO53PDB3V0 |
| M20 | IO53NDB3V0 |
| M21 | IO56PDB3V0 |
| M22 | NC |
| N1 | IO114PPB6V1 |
| N2 | IO111NDB6V1 |
| N3 | NC |
| N4 | GFC2/IO115PPB6V1 |
| N5 | IO113PPB6V1 |
| N6 | IO112PDB6V1 |
| N7 | IO112NDB6V1 |
| N8 | VCCIB6 |
| N9 | VCC |
| N10 | GND |
| N11 | GND |
| N12 | GND |
| N13 | GND |
| N14 | VCC |
| N15 | VCCIB3 |
| N16 | IO54NPB3V0 |

| FG896 | | FG896 | | FG896 | |
|------------|-------------------|------------|-------------------|------------|-------------------|
| Pin Number | A3PE3000 Function | Pin Number | A3PE3000 Function | Pin Number | A3PE3000 Function |
| AG9 | IO225NPB5V3 | AH15 | IO195NDB5V0 | AJ21 | IO173PDB4V2 |
| AG10 | IO223NPB5V3 | AH16 | IO185NDB4V3 | AJ22 | IO163NDB4V1 |
| AG11 | IO221PDB5V3 | AH17 | IO185PDB4V3 | AJ23 | IO163PDB4V1 |
| AG12 | IO221NDB5V3 | AH18 | IO181PDB4V3 | AJ24 | IO167NPB4V1 |
| AG13 | IO205NPB5V1 | AH19 | IO177NDB4V2 | AJ25 | VCC |
| AG14 | IO199NDB5V0 | AH20 | IO171NPB4V2 | AJ26 | IO156NPB4V0 |
| AG15 | IO199PDB5V0 | AH21 | IO165PPB4V1 | AJ27 | VCC |
| AG16 | IO187NDB4V4 | AH22 | IO161PPB4V0 | AJ28 | TMS |
| AG17 | IO187PDB4V4 | AH23 | IO157NDB4V0 | AJ29 | GND |
| AG18 | IO181NDB4V3 | AH24 | IO157PDB4V0 | AJ30 | GND |
| AG19 | IO171PPB4V2 | AH25 | IO155NDB4V0 | AK2 | GND |
| AG20 | IO165NPB4V1 | AH26 | VCCIB4 | AK3 | GND |
| AG21 | IO161NPB4V0 | AH27 | TDI | AK4 | IO217PPB5V2 |
| AG22 | IO159NDB4V0 | AH28 | VCC | AK5 | GND |
| AG23 | IO159PDB4V0 | AH29 | VPUMP | AK6 | IO215PPB5V2 |
| AG24 | IO158PPB4V0 | AH30 | GND | AK7 | GND |
| AG25 | GDB2/IO155PDB4V0 | AJ1 | GND | AK8 | IO207NDB5V1 |
| AG26 | GDA2/IO154PPB4V0 | AJ2 | GND | AK9 | IO207PDB5V1 |
| AG27 | GND | AJ3 | GEA2/IO233PPB5V4 | AK10 | IO201NDB5V0 |
| AG28 | VJTAG | AJ4 | VCC | AK11 | IO201PDB5V0 |
| AG29 | VCC | AJ5 | IO217NPB5V2 | AK12 | IO193NDB4V4 |
| AG30 | IO149NDB3V4 | AJ6 | VCC | AK13 | IO193PDB4V4 |
| AH1 | GND | AJ7 | IO215NPB5V2 | AK14 | IO197PDB5V0 |
| AH2 | IO233NPB5V4 | AJ8 | IO213NDB5V2 | AK15 | IO191NDB4V4 |
| AH3 | VCC | AJ9 | IO213PDB5V2 | AK16 | IO191PDB4V4 |
| AH4 | GEB2/IO232PPB5V4 | AJ10 | IO209NDB5V1 | AK17 | IO189NDB4V4 |
| AH5 | VCCIB5 | AJ11 | IO209PDB5V1 | AK18 | IO189PDB4V4 |
| AH6 | IO219NDB5V3 | AJ12 | IO203NDB5V1 | AK19 | IO179PPB4V3 |
| AH7 | IO219PDB5V3 | AJ13 | IO203PDB5V1 | AK20 | IO175NDB4V2 |
| AH8 | IO227NDB5V4 | AJ14 | IO197NDB5V0 | AK21 | IO175PDB4V2 |
| AH9 | IO227PDB5V4 | AJ15 | IO195PDB5V0 | AK22 | IO169NDB4V1 |
| AH10 | IO225PPB5V3 | AJ16 | IO183NDB4V3 | AK23 | IO169PDB4V1 |
| AH11 | IO223PPB5V3 | AJ17 | IO183PDB4V3 | AK24 | GND |
| AH12 | IO211NDB5V2 | AJ18 | IO179NPB4V3 | AK25 | IO167PPB4V1 |
| AH13 | IO211PDB5V2 | AJ19 | IO177PDB4V2 | AK26 | GND |
| AH14 | IO205PPB5V1 | AJ20 | IO173NDB4V2 | AK27 | GDC2/IO156PPB4V0 |

| Revision | Changes | Page |
|----------------------|--|------|
| v2.1 (continued) | The words "ambient temperature" were added to the temperature range in the "Temperature Grade Offerings", "Speed Grade and Temperature Grade Matrix", and "Speed Grade and Temperature Grade Matrix" sections. | 1-I |
| | The "Clock Conditioning Circuit (CCC) and PLL" section was updated. | 1-I |
| | The caption "Main (chip)" in Figure 2-9 • Overview of Automotive ProASIC3 VersaNet Global Network was changed to "Chip (main)." | 2-9 |
| | The T_J parameter in Table 3-2 • Recommended Operating Conditions was changed to T_A , ambient temperature, and table notes 4–6 were added. | 3-2 |
| | The "PLL Macro" section was updated to add information on the VCO and PLL outputs during power-up. | 2-15 |
| v2.0 (April 2007) | In the "Temperature Grade Offerings" section, Ambient was deleted. | iii |
| | Ambient was deleted from "Temperature Grade Offerings". | iii |
| | Ambient was deleted from the "Speed Grade and Temperature Grade Matrix". | iv |
| | The "PLL Macro" section was updated to include power-up information. | 2-15 |
| | Table 2-13 • ProASIC3E CCC/PLL Specification was updated. | 2-30 |
| | Figure 2-19 • Peak-to-Peak Jitter Definition is new. | 2-18 |
| | The "SRAM and FIFO" section was updated with operation and timing requirement information. | 2-21 |
| | The "RESET" section was updated with read and write information. | 2-25 |
| | The "RESET" section was updated with read and write information. | 2-25 |
| | The "Introduction" in the "Advanced I/Os" section was updated to include information on input and output buffers being disabled. | 2-28 |
| | In the Table 2-15 • Levels of Hot-Swap Support, the ProASIC3 compliance descriptions were updated for levels 3 and 4. | 2-34 |
| | Table 2-45 • I/O Hot-Swap and 5 V Input Tolerance Capabilities in ProASIC3E Devices was updated. | 2-64 |
| | Notes 3, 4, and 5 were added to Table 2-17 • Comparison Table for 5 V–Compliant Receiver Scheme. 5 x 52.72 was changed to 52.7 and the Maximum current was updated from 4 x 52.7 to 5 x 52.7. | 2-40 |
| | The "VCCPLF PLL Supply Voltage" section was updated. | 2-50 |
| | The "VPUMP Programming Supply Voltage" section was updated. | 2-50 |
| | The "GL Globals" section was updated to include information about direct input into quadrant clocks. | 2-51 |
| | VJTAG was deleted from the "TCK Test Clock" section. | 2-51 |
| | In Table 2-22 • Recommended Tie-Off Values for the TCK and TRST Pins, TSK was changed to TCK in note 2. Note 3 was also updated. | 2-51 |
| | Ambient was deleted from Table 3-2 • Recommended Operating Conditions. VPUMP programming mode was changed from "3.0 to 3.6" to "3.15 to 3.45". | 3-2 |
| | Note 3 is new in Table 3-4 • Overshoot and Undershoot Limits (as measured on quiet I/Os). | 3-2 |
| | In EQ 3-2, 150 was changed to 110 and the result changed to 5.88. | 3-5 |



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